

General Description

The WSD46N10DN56 is the highest performance SGT Dual N-Channel MOSFET with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The WSD46N10DN56 meet the RoHS and Green Product requirement, 100% E_{AS} guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

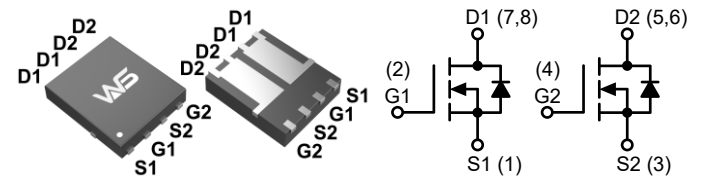
Product Summary

BV_{DSS}	$R_{DS(ON)}$	I_D
100V	14m Ω	40A

Applications

- DC-DC Converter.
- Motor Control.

DFN5X6-8L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	± 20	
$I_D@T_C=25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	40	A
$I_D@T_C=100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	33	
I_{DM}^1	Pulsed Drain Current	120	
E_{AS}^2	Single Pulse Avalanche Energy	57	mJ
I_{AS}^2	Avalanche Current	26	A
$P_D@T_C=25^\circ C$	Total Power Dissipation	71	W
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ C$
T_J	Operating Junction Temperature Range	-55 to 150	

Thermal Data

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JA}^3$	Thermal Resistance Junction-ambient	---	25	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance Junction-Case	---	1.7	

Electrical Characteristics (T_J=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	100	---	---	V
ΔBV _{DSS} /ΔT _J	BV _{DSS} Temperature Coefficient	Reference to 25°C, I _D =1mA	---	0.098	---	V/°C
R _{DS(ON)} ⁴	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =10A	---	14	20	mΩ
		V _{GS} =4.5V, I _D =7A	---	18	30	
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250μA	1.2	1.5	2.5	V
ΔV _{GS(th)}	V _{GS(th)} Temperature Coefficient		---	5.52	---	mV/°C
I _{DSS}	Drain-Source Leakage Current	V _{DS} =80V, V _{GS} =0V, T _J =25°C	---	---	1.0	μA
		V _{DS} =80V, V _{GS} =0V, T _J =55°C	---	---	30	
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V, V _{DS} =0V	---	---	±100	nA
R _g ⁵	Gate Resistance	V _{DS} =0V, V _{GS} =0V, f = 1.0MHz	---	1.2	---	Ω
Q _g ⁵	Total Gate Charge (10V)	V _{DS} =50V, V _{GS} =10V, I _D =5A	---	17	---	nC
Q _{gs} ⁵	Gate-Source Charge		---	2.8	---	
Q _{gd} ⁵	Gate-Drain Charge		---	4.1	---	
T _{d(on)} ⁵	Turn-On Delay Time	V _{DD} =30V, V _{GEN} =10V, R _G =6Ω, I _D =1A, R _L =30Ω	---	16	---	ns
T _r ⁵	Rise Time		---	3.8	---	
T _{d(off)} ⁵	Turn-Off Delay Time		---	75	---	
T _f ⁵	Fall Time		---	46	---	
C _{iss} ⁵	Input Capacitance	V _{DS} =50V, V _{GS} =0V, f=1.0MHz	---	1010	---	pF
C _{oss} ⁵	Output Capacitance		---	185	---	
C _{rss} ⁵	Reverse Transfer Capacitance		---	12	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
I _S	Continuous Source Current	V _G =V _D =0V, Force Current	---	---	30	A
V _{SD} ⁴	Diode Forward Voltage	V _{GS} =0V, I _S =-1A, T _J =25°C	---	---	1.2	V
t _{rr}	Reverse Recovery Time	I _S =1A, di/dt=100A/μs	---	49	---	ns
Q _{rr}	Reverse Recovery Charge		---	62	---	nC

Note:

- Pulse width limited by max. junction temperature.
- UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature T_J=25°C).
- Surface Mounted on 1in² pad area.
- Pulse test; pulse width≤300μs, duty cycle≤2%.
- Guaranteed by design, not subject to production testing.

Typical Characteristics

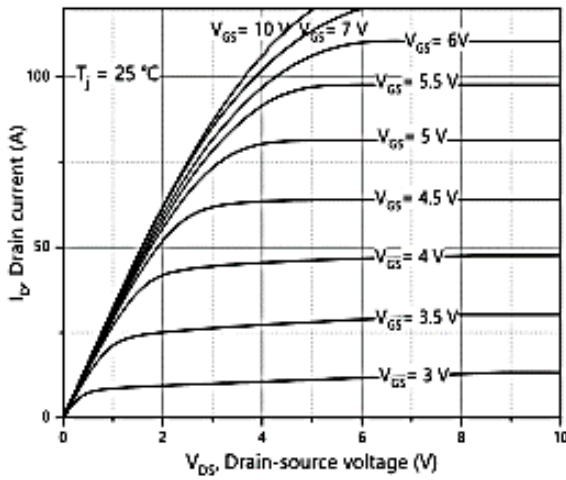


Figure 1, Typ. output characteristics

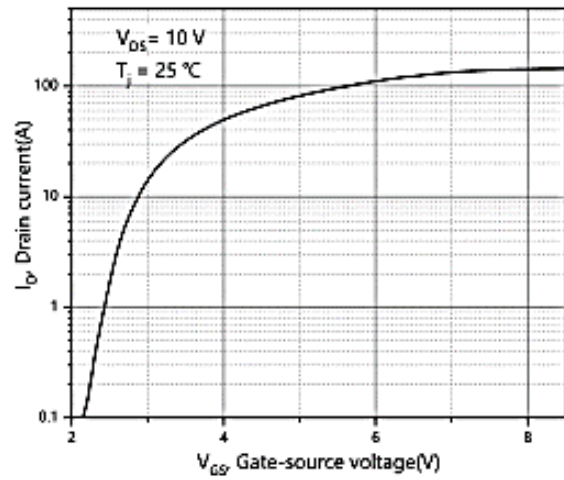


Figure 2, Typ. transfer characteristics

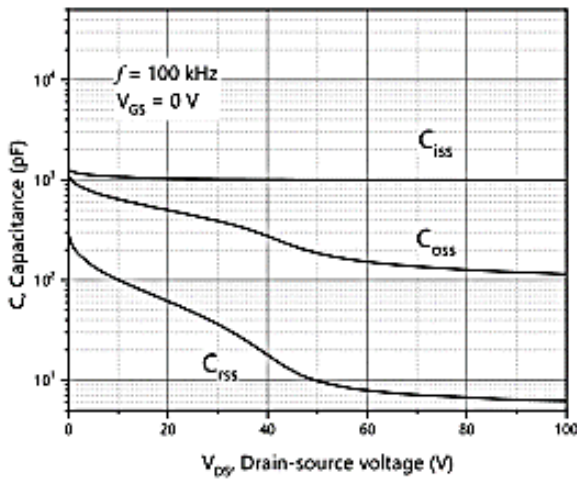


Figure 3, Typ. capacitances

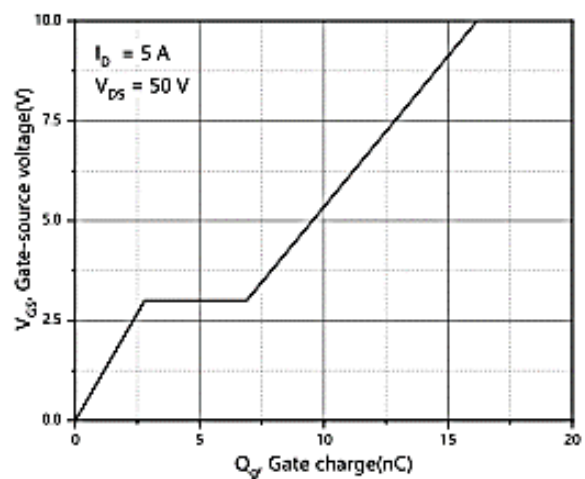


Figure 4, Typ. gate charge

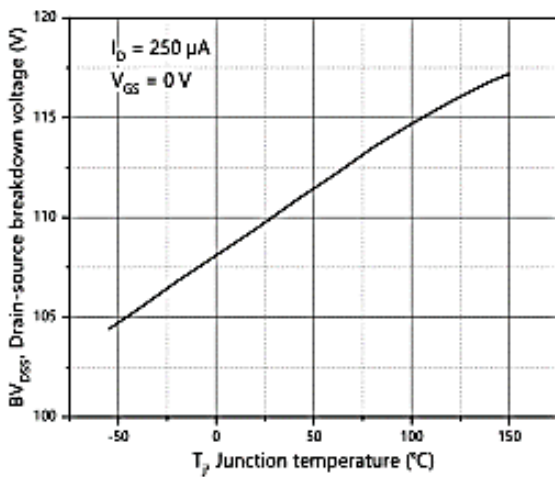


Figure 5, Drain-source breakdown voltage

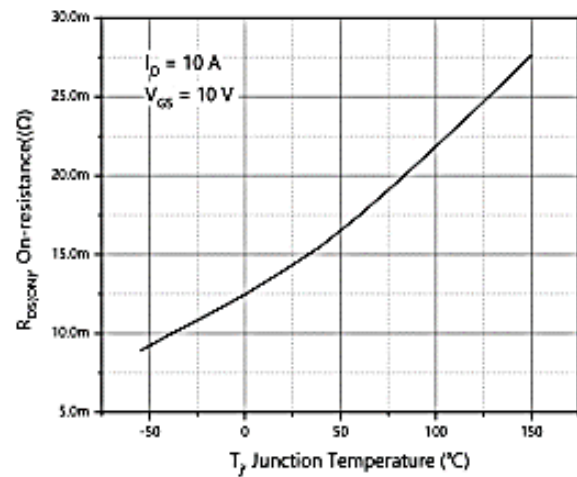


Figure 6, Drain-source on-state resistance

Typical Characteristics (Cont.)

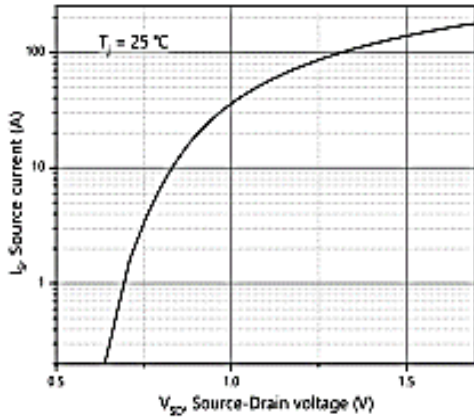


Figure 7, Forward characteristic of body diode

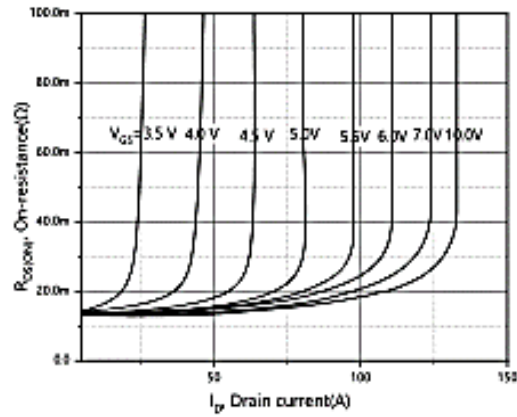


Figure 8, Drain-source on-state resistance

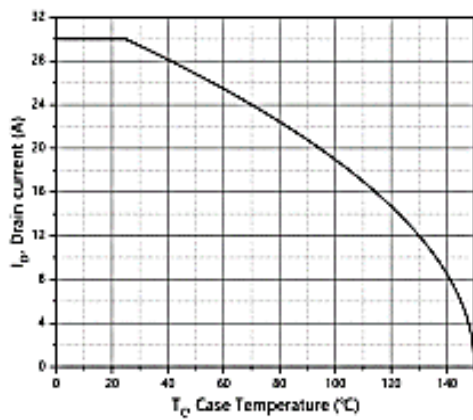


Figure 9, Drain current

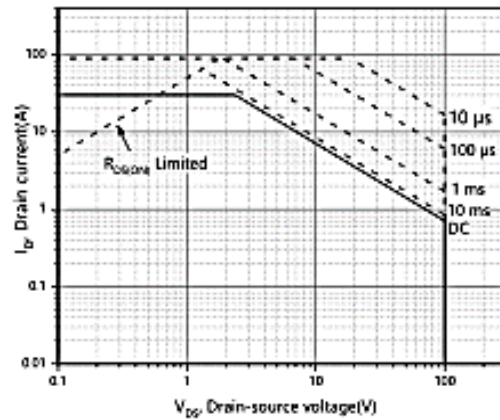


Figure 10, Safe operation area $T_c = 25\text{ }^\circ\text{C}$

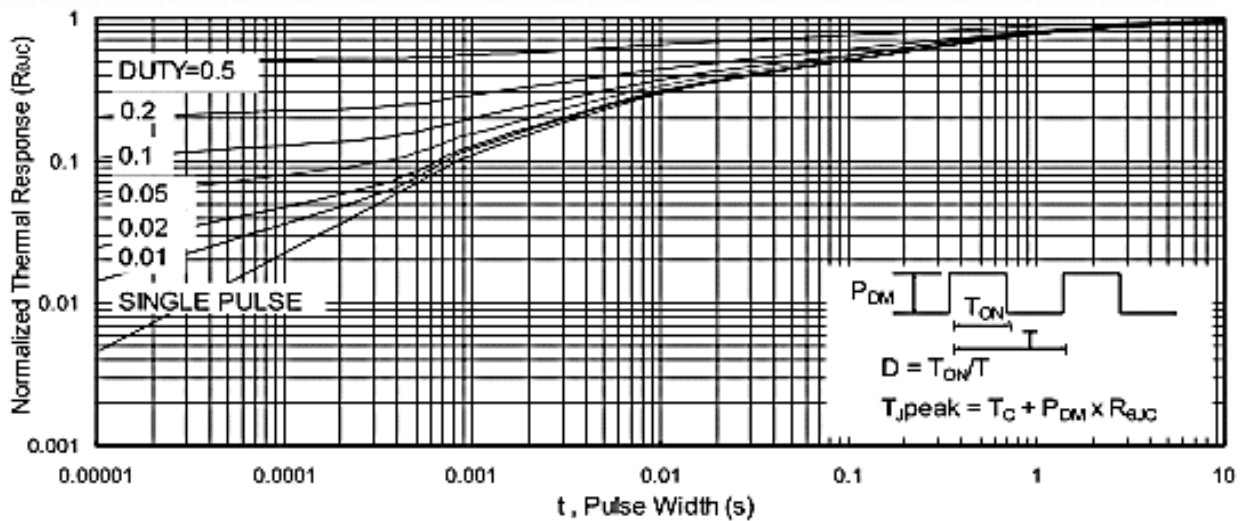
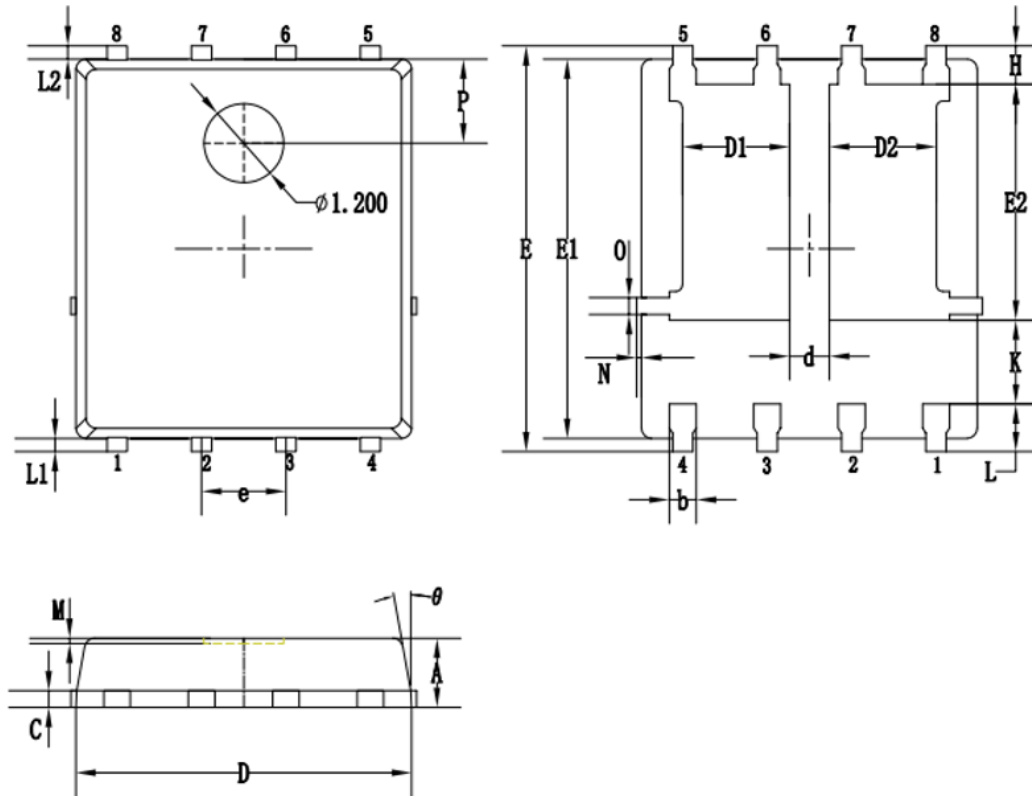


Fig11. Normalized Maximum Transient Thermal Impedance

Packaging information


SYMBOLS	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.05	1.20
b	0.35	0.40	0.50
C	0.20	0.25	0.35
D	4.90	5.05	5.20
D1/D2	1.51	1.61	1.71
d	0.50	0.60	0.70
E	6.00	6.15	6.30
E1	5.60	5.75	5.90
E2	3.47	3.57	3.67
e	1.27 BSC.		
H	0.48	0.58	0.68
K	1.17	1.27	1.37
L	0.64	0.74	0.84
L1/L2	0.20 REF.		
θ	8°	10°	12°
M	0.08 REF.		
N	0	-	0.15
O	0.25 REF.		
P	1.28 REF.		

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